IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re Application of:)
Chen, et al.) Confirmation No.: 9818
Serial No.: 10/810,965) Examiner: Trinh, Hoa B.
Filed: March 26, 2004) Group Art Unit: 2814
For: Novel Method to Improve Bump Reliability for Flip Chip Device) TKHR Docket: 252016-2530) Top-Team: 0503-A30731US

RESPONSE TO FINAL OFFICE ACTION

Mail Stop AF Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Sir:

The FINAL Office Action mailed April 24, 2005 has been carefully considered. In response thereto, please consider the following remarks.